


Search Notes 	Application/Control No. 10589915	Applicant(s)/Patent Under Reexamination CHONG ET AL.
	Examiner ROBERT HUBER	Art Unit 2892

SEARCHED			
Class	Subclass	Date	Examiner
257	314, 613	5/14/08	RH
711	104	5/14/08	RH
257	2 - 5	12/8/08	RH
257	E45.002	1/12/10	RH

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search - EAST (USPAT, USPGPUB, USOCR) - see printout	5/13/08	RH
PLUS search - keywords: chalcogenide, phase, change, pcram, multiple, plurality, many, layer, film, memory, temperature, electrode, contact	5/14/08	RH
EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	5/13/08 - 5/15/08, 5/21/08	RH
Suggested EAST Search from Thao Le: @ad<= 20040219 and GeTe same Sb.sub.2Te.sub.3	5/21/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	12/8/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	5/21/09	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout.	1/12/10	RH
.clm. search - EAST (USPAT, USPGPUB, UPAD) - see printout	1/12/10	RH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	2 - 5, 52, 613, 758, E45.002	1/12/10	RH

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